

<b>Search Notes</b> 				<b>Application/Control No.</b> 10/722,532 <b>Examiner</b> Patricia T. Nguyen	<b>Applicant(s)/Patent under Reexamination</b> AKAMINE ET AL. <b>Art Unit</b> 2817	
<b>SEARCHED</b>				<b>SEARCH NOTES (INCLUDING SEARCH STRATEGY)</b>		
Class	Subclass	Date	Examiner		DATE	EXMR
330	133	2/25/2005	PN			
"	127	"	"			
<b>INTERFERENCE SEARCHED</b>						
Class	Subclass	Date	Examiner			
330	133	3/7/2005	PN			
"	127	"	"			